PACKAGE/ORDERING INFORMATION

MODEL	PACKAGE SPECIFIED TEMPERATURE RANGE		ORDERING NUMBER	PACKAGE MARKING	PACKING OPTION	
SGM44603	TQFN-2.6×1.8-16L	-40°C to +85°C	SGM44603YTQA16/TR	44603 XXXXX	Tape and Reel, 3000	

MARKING INFORMATION

NOTE: XXXXX = Date Code and Vendor Code.



Green (RoHS & HSF): SG Micro Corp defines "Green" to mean Pb-Free (RoHS compatible) and free of halogen substances. If you have additional comments or questions, please contact your SGMICRO representative directly.

ABSOLUTE MAXIMUM RATINGS

V ₊ to GND	0.3V to 6V
Analog, Digital Voltage Range (1)	0.3V to (V ₊) +0.3V
Continuous Current NO, NC, or COM	±100mA
Junction Temperature	+150°C
Storage Temperature Range	65°C to +150°C
Lead Temperature (Soldering, 10s)	+260°C

NOTE:

1. Signals on NC, NO, or COM or IN_X exceeding V_+ will be clamped by internal diodes. Limit forward diode current to maximum current ratings.

RECOMMENDED OPERATING CONDITIONS

Operating Temperature Range-40°C to +85°C

OVERSTRESS CAUTION

Stresses beyond those listed in Absolute Maximum Ratings may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect reliability. Functional operation of the device at any conditions beyond those indicated in the Recommended Operating Conditions section is not implied.

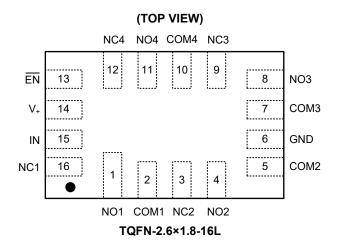
ESD SENSITIVITY CAUTION

This integrated circuit can be damaged by ESD if you don't pay attention to ESD protection. SGMICRO recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

DISCLAIMER

SG Micro Corp reserves the right to make any change in circuit design, or specifications without prior notice.

PIN CONFIGURATION



PIN DESCRIPTION

NAME	PIN	FUNCTION				
V ₊	14	Power Supply.				
GND	6	Ground.				
IN	15	Digital Control Pin to Connect the COM Terminal to the NO or NC Terminals.				
ĒN	13	Digital Enable Input. Normally connect to GND. Drive to logic high to set all switches off.				
COM _X	2, 5, 7, 10	Common Terminal.				
NO _X	1, 4, 8, 11	Normally-Open Terminal.				
NC _X	16, 3, 9, 12	Normally-Closed Terminal.				

NOTE: NO_X, NC_X and COM_X terminals may be an input or output.

FUNCTION TABLE

EN	IN	NO	NC		
L	L	OFF	ON		
L	Н	ON	OFF		
Н	$\sqrt{}$	All Switches Open			

 $\sqrt{\ }$ = Don't Care.

ELECTRICAL CHARACTERISTICS

 $(V_+ = +4.5V \text{ to } +5.5V, \text{ GND} = 0V, V_{\text{IH}} = +1.6V, V_{\text{IL}} = +0.5V, \text{ Full} = -40^{\circ}\text{C} \text{ to } +85^{\circ}\text{C}. \text{ Typical values are at } V_+ = +5.0V, T_A = +25^{\circ}\text{C}, \text{ unless otherwise noted.})$

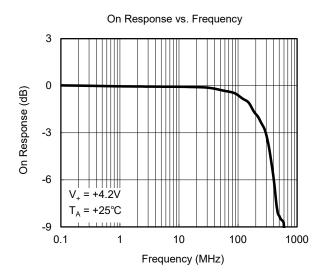
PARAMETER	SYMBOL	CONDITIONS		TEMP	MIN	TYP	MAX	UNITS
Analog Switch						•		•
Analog Signal Range	V_{NO},V_{NC},V_{COM}			Full	0		V+	V
On Besistance	Б	$V_+ = 4.5V$, $0V \le V_{NO}$ or $V_{NC} \le V_+$, $I_{COM} = -100$ mA, Test Circuit 1		+25°C		4.5	7	Ω
On-Resistance	R_{ON}			Full			8	
On-Resistance Match between	A.D.	$V_{+} = 4.5V, \ 0V \le V_{NO} \ or \ V_{NC} :$	$V_{+} = 4.5 \text{V}, \ 0 \text{V} \le \text{V}_{NO} \ \text{or} \ \text{V}_{NC} \le \text{V}_{+},$			0.8	3.6	Ω
Channels	ΔR_{ON}	I _{COM} = -100mA, Test Circuit 1		Full			4.2	
On-Resistance Flatness	В	$V_{+} = 4.5V, \ 0V \le V_{NO} \ or \ V_{NC}$	≤ V ₊ ,	+25°C		3	3.7	- Ω
On-Nesistance Flatness	$R_{FLAT(ON)}$	I _{COM} = -100mA, Test Circuit	1	Full			4.5	12
Source Off Leakage Current	I _{NC(OFF)} , I _{NO(OFF)}	$V_{+} = 5.5V$, V_{NO} or $V_{NC} = 3.3V$ $V_{COM} = 0.3V/3.3V$	//0.3V,	Full			1	μA
Channel On Leakage Current	$I_{NC(ON)}, I_{NO(ON)}, I_{COM(ON)}$	V_{+} =5.5V, V_{COM} = 0.3V/3.3V V_{NO} or V_{NC} = 0.3V/3.3V or fl		Full			1	μA
Digital Inputs								
Input High Voltage	V _{INH}			Full	1.6			V
Input Low Voltage	V _{INL}						0.5	V
Input Leakage Current	I _{IN}	$V_{+} = 5.5V, V_{IN}, V_{\overline{EN}} = 0V \text{ or } V_{\overline{EN}}$	V ₊	Full			1	μΑ
Dynamic Characteristics								
Turn-On Time	t _{on}	V_{NO} or V_{NC} = 3V, C_L = 35pF,		+25°C		40		ns
Turn-Off Time	t _{OFF}	R_L = 300Ω, Test Circuit 2		+25°C		30		ns
Charge Injection Select Input to Common I/O	Q	$V_G = GND, R_G = 0\Omega, C_L = 10$ $Q = C_L \times V_{OUT}$, Test Circuit 3		+25°C		20		рС
Break-Before-Make Time Delay	t _D	V_{NO} or V_{NC} = 3V, R_L = 300 Ω C_L = 35pF, Test Circuit 4	,	+25°C		18		ns
Off In alastica	0	$R_L = 50\Omega$, Signal = 0dBm,	1MHz	+25°C		-70		dB
Off Isolation	O _{ISO}	Test Circuit 5	10MHz	+25°C		-50		иь
Channel-to-Channel Crosstalk	V	$R_L = 50\Omega$, Signal = 0dBm,	1MHz	+25°C		-90		dB
Channel-to-Channel Crosstalk	X_{TALK}	Test Circuit 6	10MHz	+25°C		-60		
-3dB Bandwidth	BW	R _L = 50Ω, Signal = 0dBm, Test Circuit 7		+25°C		300		MHz
Channel On Capacitance	C _{ON}		+25°C		64		pF	
Power Requirements				•				
Power Supply Range	V ₊		Full	1.8		5.5	V	
Power Supply Current	I+	$V_{+} = 5.5V, V_{S}, V_{\overline{EN}} = 0V \text{ or } V_{\overline{EN}}$	Full			1	μA	

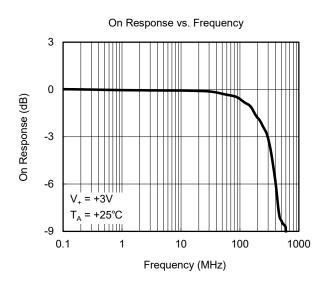
ELECTRICAL CHARACTERISTICS (continued)

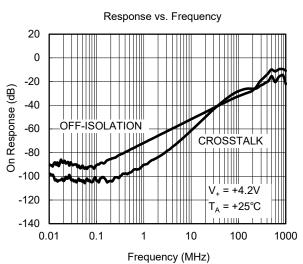
 $(V_+ = +2.7V \text{ to } +3.6V, V_{IH} = +1.6V, V_{IL} = +0.4V, \text{ Full} = -40^{\circ}\text{C} \text{ to } +85^{\circ}\text{C}. \text{ Typical values are at } V_+ = +3.0V, T_A = +25^{\circ}\text{C}, \text{ unless otherwise noted.})$

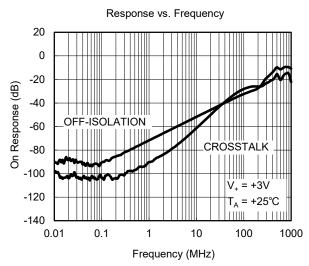
PARAMETER	SYMBOL	CONDITIONS		TEMP	MIN	TYP	MAX	UNITS
Analog Switch							•	
Analog Signal Range	V_{NO},V_{NC},V_{COM}		Full	0		V+	V	
On-Resistance	-	$V_{+} = 2.7V, \ 0V \le V_{NO} \ or \ V_{NC} \le V_{+},$		+25°C		11	15.5	Ω
OII-Resistance	R _{on}	I _{COM} = -100mA, Test Circuit	1	Full			18.5	1 12
On-Resistance Match between	ΔR_{ON}	$V_{+} = 2.7V, \ 0V \le V_{NO} \ or \ V_{NC} \le V_{NC} \ or \ V_{NC} \ or \ V_{NC} \le V_{NC} \ or \ or \ V_{NC} \ or \ V_{NC} \ or \ V_{NC} \ or \ V_{NC} \ or \ O$	$V_{+} = 2.7V, \ 0V \le V_{NO} \ \text{or} \ V_{NC} \le V_{+},$			1.6	4	
Channels	ΔKON	I _{COM} = -100mA, Test Circuit	1	Full			4.6	Ω
On-Resistance Flatness	R _{FLAT(ON)}	$V_{+} = 2.7V, 0V \le V_{NO} \text{ or } V_{NC} \le$	≤ V ₊ ,	+25°C		7	9.4	Ω
On-Nesistance Flatness	NFLAT(ON)	I _{COM} = -100mA, Test Circuit	1	Full			13	12
Source Off Leakage Current	I _{NC(OFF)} , I _{NO(OFF)}	$V_{+} = 3.6V$, V_{NO} or $V_{NC} = 3.3V$ $V_{COM} = 0.3V/3.3V$	//0.3V,	Full			1	μΑ
Channel On Leakage Current	$I_{NC(ON)}, I_{NO(ON)}, I_{COM(ON)}$	$V_{+} = 3.6V$, $V_{COM} = 0.3V/3.3V$ V_{NO} or $V_{NC} = 0.3V/3.3V$ or flo	, pating	Full			1	μΑ
Digital Inputs								
Input High Voltage	V _{INH}			Full	1.5			V
Input Low Voltage	V _{INL}			Full			0.4	V
Input Leakage Current	I _{IN}	$V_{+} = 2.7V, V_{IN}, V_{\overline{EN}} = 0V \text{ or }$	V+	Full			1	μΑ
Dynamic Characteristics							_	
Turn-On Time	t _{on}	V_{NO} or $V_{NC} = 1.5V$, $C_{L} = 35p$	F,	+25°C		48		ns
Turn-Off Time	t _{OFF}	R_L = 300Ω, Test Circuit 2		+25°C		45		ns
Charge Injection Select Input to Common I/O	Q	$V_G = GND, R_G = 0\Omega, C_L = 1n$ $Q = C_L \times V_{OUT}$, Test Circuit 3		+25°C		20		рС
Break-Before-Make Time Delay	t _D	V_{NO} or V_{NC} = 1.5V, R_L = 300 C_L = 35pF, Test Circuit 4	Ω,	+25°C		20		ns
Off landation	0	$R_L = 50\Omega$, Signal = 0dBm,	1MHz	+25°C		-70		-10
Off Isolation	O _{ISO}	Test Circuit 5	10MHz	+25°C		-50		dB
Observed to Observed Oncortally	X _{TALK}	R _L = 50 Ω, Signal = 0dBm, Test Circuit 6	1MHz	+25°C		-90		
Channel-to-Channel Crosstalk			10MHz	+25°C		-60		dB
-3dB Bandwidth	BW	R _L = 50Ω, Signal = 0dBm, Test Circuit 7		+25°C		300		MHz
Channel On Capacitance	C _{ON}			+25°C		64		pF

TYPICAL PERFORMANCE CHARACTERISTICS

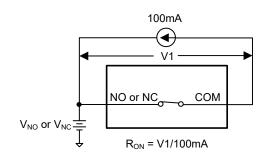




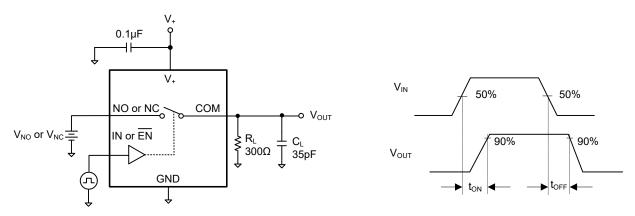




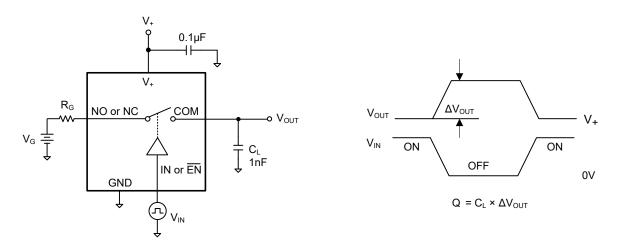
TEST CIRCUITS



Test Circuit 1. On-Resistance

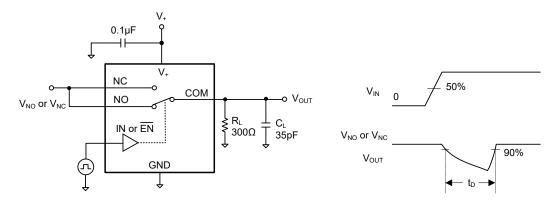


Test Circuit 2. Switching Times

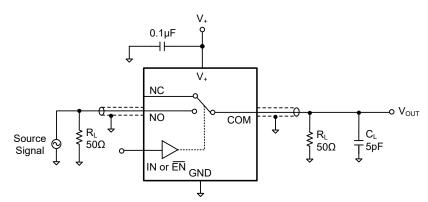


Test Circuit 3. Charge Injection

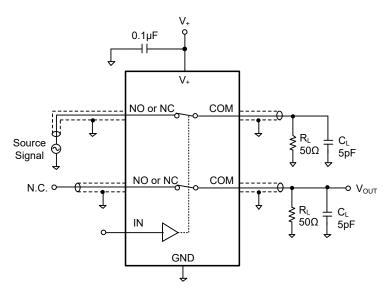
TEST CIRCUITS (continued)



Test Circuit 4. Break-Before-Make Time Delay (tD)



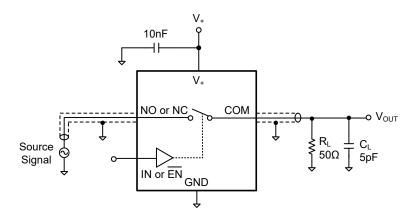
Test Circuit 5. Off Isolation



Channel-to-Channel Crosstalk = -20×log $\frac{V_{NO} \text{ or } V_{NC}}{V_{OUT}}$

Test Circuit 6. Channel-to-Channel Crosstalk

TEST CIRCUITS (continued)



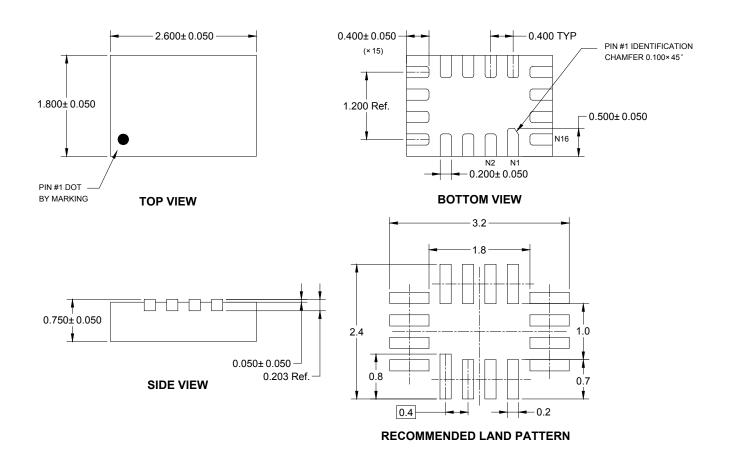
Test Circuit 7. -3dB Bandwidth

REVISION HISTORY

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

MAY 2016 - REV.A.3 to REV.A.4	Page
Updated Package Outline Dimensions section	10
Updated Tape and Reel Information section	12
JANUARY 2013 – REV.A.2 to REV.A.3	Page
Updated Package Outline Dimensions section	10
Updated Tape and Reel Information section	11, 12
MAY 2011 – REV.A.1 to REV.A.2	Page
Updated package name	All
DECEMBER 2008 – REV.A to REV.A.1	Page
Updated typeset	All
Changes from Original (MAY 2008) to REV.A	Page
Changed from product preview to production data	All

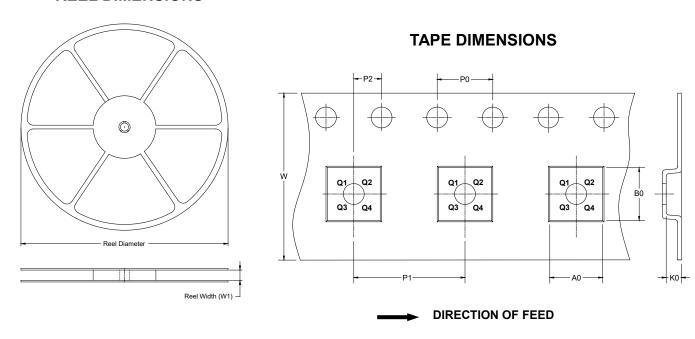
PACKAGE OUTLINE DIMENSIONS TQFN-2.6×1.8-16L



NOTE: All linear dimensions are in millimeters.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

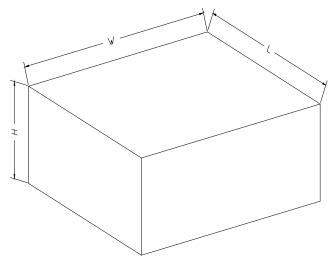


NOTE: The picture is only for reference. Please make the object as the standard.

KEY PARAMETER LIST OF TAPE AND REEL

Package Type	Reel Diameter	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P0 (mm)	P1 (mm)	P2 (mm)	W (mm)	Pin1 Quadrant
TQFN-2.6×1.8-16L	7"	9.0	2.01	2.81	0.93	4.0	4.0	2.0	8.0	Q1

CARTON BOX DIMENSIONS



NOTE: The picture is only for reference. Please make the object as the standard.

KEY PARAMETER LIST OF CARTON BOX

Reel Type	Length (mm)	Width (mm)	Height (mm)	Pizza/Carton
7" (Option)	368	227	224	8
7"	442	410	224	18